



Form 1449 (Modified)	Atty Docket No. IGT1P034/P-277	Application No.: 09/732,650
Information Disclosure Statement By Applicant	Applicant: Nguyen	
(Use Several Sheets if Necessary)	Filing Date December 7, 2000	Group 2134

U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub- class	Filing Date
AN	A1	6,264,561	7/24/2001	Saffari, et al.			10/01/1998

Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
AN	B1	Copy of U.S. Patent Application No. 09/520,404 (30 pages)
Examiner	Date Considered	
CA	12/09/00	

Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



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	Applicant: Binh T. Nguyen	
	Filing Date 12/7/00	Group 2132

U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
AP	A1	6,099,408	8/8/00	Schneier et al.	463	29	12/31/96
AP	A2	5,768,382	6/16/98	Schneier et al.	380	23	11/22/95
AP	A3	6,285,868	9/4/01	LaDue	455	410	1/10/97
AP	A4	6,178,510	1/23/01	O'Connor et al.	713	201	9/4/97

Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
AP	B1	WO 96/00950	11/1/96	WIPO	G06F	155/00	X	
AP	B2	WO 95/24689	14/9/95	WIPO	G06F	155/00	X	
AP	B3	WO 99/01188	14/1/99	WIPO	A63F	—	X	

Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
Examiner		Date Considered
Andrew Nalun		5/5/04

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U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
<i>AN</i>	A	6,002,772	Dec. 14, 1999	Saito			Apr. 2, 1997
	B						
	C						
	D						
	E						
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	I						

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Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
<i>AN</i>	J	1074955A2	07/02/2001	EPO			X	
<i>AN</i>	K	1061430A1	20/12/2000	EPO			X	
<i>AN</i>	L	0715245A1	05/06/1996	EPO			X	
<i>AN</i>	M	02/05229A2	17/01/2002	WIPO			X	
	N							

Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
	O	
	P	
	Q	
Examiner <i>Andrew Nalvey</i>		Date Considered <i>5/5/04</i>

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U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub- class	Filing Date
AP	A1	2002/0045477	04/18/2002	Dabrowski	463	29	08/27/2001
AP	A2	2002/0071557	06/13/2002	Nguyen	380	251	12/07/2000

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Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub- class	Translation	
							Yes	No
AP	B1	EP 0744786	27.11.1996	EP			X	

Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
Examiner	Date Considered	
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